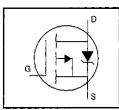
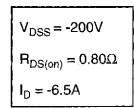


## HEXFET® Power MOSFET

- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- · Fast Switching
- Ease of Paralleling





## Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.



## **Absolute Maximum Ratings**

	Parameter	Max.	Units	
i <sub>D</sub> @ T <sub>C</sub> = 25°C Continuous Drain Current, V <sub>GS</sub> @ -10 V		-6.5		
I <sub>D</sub> @ T <sub>C</sub> = 100°C	D @ T <sub>C</sub> = 100°C Continuous Drain Current, V <sub>GS</sub> @ -10 V -4.0		Α	
DM Pulsed Drain Current ①		-26		
Pp @ Tc = 25°C	Power Dissipation	74	w	
PD @ TA = 25°C	Power Dissipation (PCB Mount)**	3.0		
	Linear Derating Factor	0.59	- W/°C	
	Linear Derating Factor (PCB Mount)**	0.025	- W/-C	
V <sub>GS</sub>	Gate-to-Source Voltage	±20	Λ	
Eas	Single Pulse Avalanche Energy ②	500	mJ	
laB	Avalanche Current ①	-6.4	A	
EAR	Repetitive Avalanche Energy ①	7.4	mJ	
dv/dt	Peak Diode Recovery dv/dt ③	-5.0	V/ns	
TJ, TSTG	Junction and Storage Temperature Range	-55 to +150	— ~c	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)		

#### Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
Rωc	Junction-to-Case	_	_	1.7	
Reja	Junction-to-Ambient (PCB mount)**	l	-	40	°C/W
Raja	Junction-to-Ambient	l –	_	62	

<sup>\*\*</sup> When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.



# Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	-200	_	_	٧	V <sub>GS</sub> =0V, i <sub>D</sub> =-250μA
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	_	-0.24	_	V/°C	Reference to 25°C, I <sub>D</sub> =-1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		_	0.80	Ω	V <sub>GS</sub> =-10V, I <sub>D</sub> =-3.9A
V <sub>GS(th)</sub>	Gate Threshold Voltage	-2.0	_	-4.0	٧	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA
g <sub>fs</sub>	Forward Transconductance	2.8		_	S	V <sub>DS</sub> =-50V, I <sub>D</sub> =-3.9A
Ipss	Brain to Source Leakage Correct	_	_	-100		V <sub>DS</sub> =-200V, V <sub>GS</sub> =0V
L	Drain-to-Source Leakage Current	_	_	-500	μΑ	V <sub>DS</sub> =-160V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			-100	nA	V <sub>GS</sub> =-20V
1488	Gate-to-Source Reverse Leakage	—		100	] MA	V <sub>GS</sub> =20V
Qg	Total Gate Charge		_	29		In=-6.5A
Qgs	Gate-to-Source Charge	_	_	5.4	nC	V <sub>DS</sub> =-160V
Qgd	Gate-to-Drain ("Miller") Charge	_	-	15		V <sub>GS</sub> =-10V See Fig. 6 and 13 @
t <sub>d(on)</sub>	Turn-On Delay Time	_	12			V <sub>DD</sub> =-100V
t <sub>r</sub>	Rise Time	_	27	_	ns	I <sub>D</sub> =-6.5A
ta(off)	Turn-Off Delay Time		28		115	R <sub>G</sub> =12Ω
t <sub>1</sub>	Fall Time	_	24	_		R <sub>D</sub> =15Ω See Figure 10 ④
LD	Internal Drain Inductance	_	4.5	<u> </u>	nН	Between lead, 6 mm (0.25in.)
Ls	Internal Source Inductance		7.5	_		from package and center of die contact
Ciss	Input Capacitance	_	700			V <sub>GS</sub> =0V
Coss	Output Capacitance		200	_	pF	V <sub>DS</sub> =-25V
Crss	Reverse Transfer Capacitance		40	_	ļ	f=1.0MHz See Figure 5

# Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Мах.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)	-	_	-6.5		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①		!	-26	Α	integral reverse of p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage		_	-6.5	V	TJ=25°C, IS=-6.5A, VGS=0V @
trr	Reverse Recovery Time	_   -	200	300	ns	TJ=25°C, IF=-6.5A
Qrr	Reverse Recovery Charge		1.9	2.9	μC	di/dt=100A/μs @
t <sub>on</sub> .	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+LD)			

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ③ Isp≤-6.5A, di/dt≤120A/ $\mu$ s, V<sub>DD</sub>≤V(BR)DSS, TJ≤150°C
- ② V<sub>DD</sub>=-50V, starting T<sub>J</sub>=25°C, L=17mH R<sub>G</sub>=25Ω, I<sub>A</sub>S=-6.5A (See Figure 12)
- 4 Pulse width  $\leq 300~\mu s$ ; duty cycle  $\leq 2\%$ .

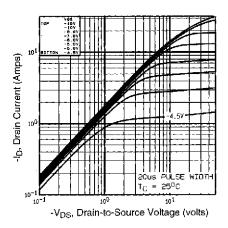


Fig 1. Typical Output Characteristics, T<sub>C</sub>=25°C

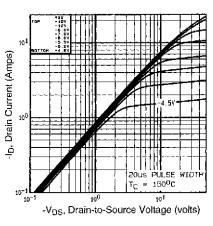


Fig 2. Typical Output Characteristics, Tc=150°C

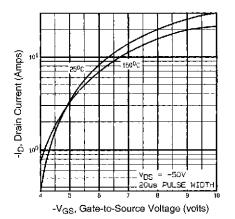


Fig 3. Typical Transfer Characteristics

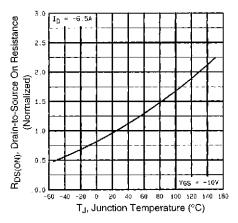


Fig 4. Normalized On-Resistance Vs. Temperature

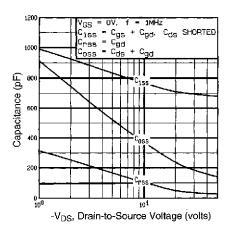


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

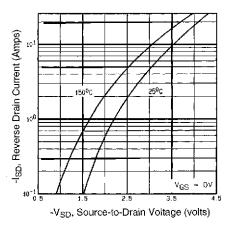
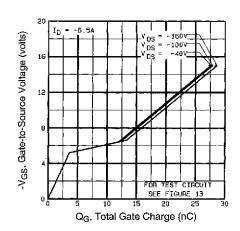


Fig 7. Typical Source-Drain Diode Forward Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

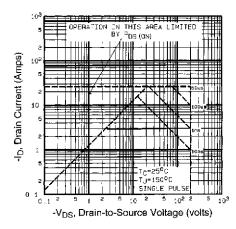


Fig 8. Maximum Safe Operating Area

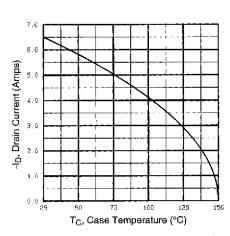


Fig 9. Maximum Drain Current Vs. Case Temperature

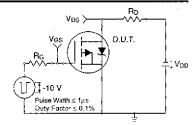


Fig 10a. Switching Time Test Circuit

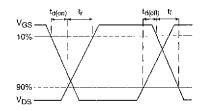


Fig 10b. Switching Time Waveforms

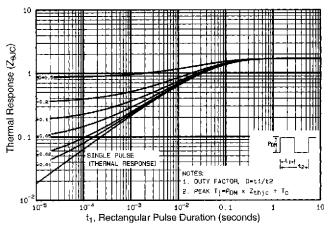


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

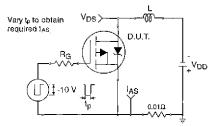


Fig 12a. Unclamped Inductive Test Circuit

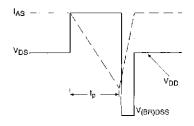
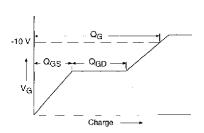


Fig 12b. Unclamped Inductive Waveforms



Flg 13a. Basic Gate Charge Waveform

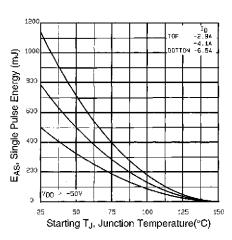


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

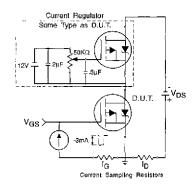


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit - See page 1506

Appendix B: Package Outline Mechanical Drawing - See page 1507

Appendix C: Part Marking Information – See page 1515

Appendix D: Tape & Reel Information – See page 1519

International Rectifier



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